

## Description

IRFP240, the silicon N-channel Enhanced MOSFETs, is obtained by advanced MOSFET technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor is suitable device for SMPS, high speed switching and general purpose applications.

## KEY CHARACTERISTICS

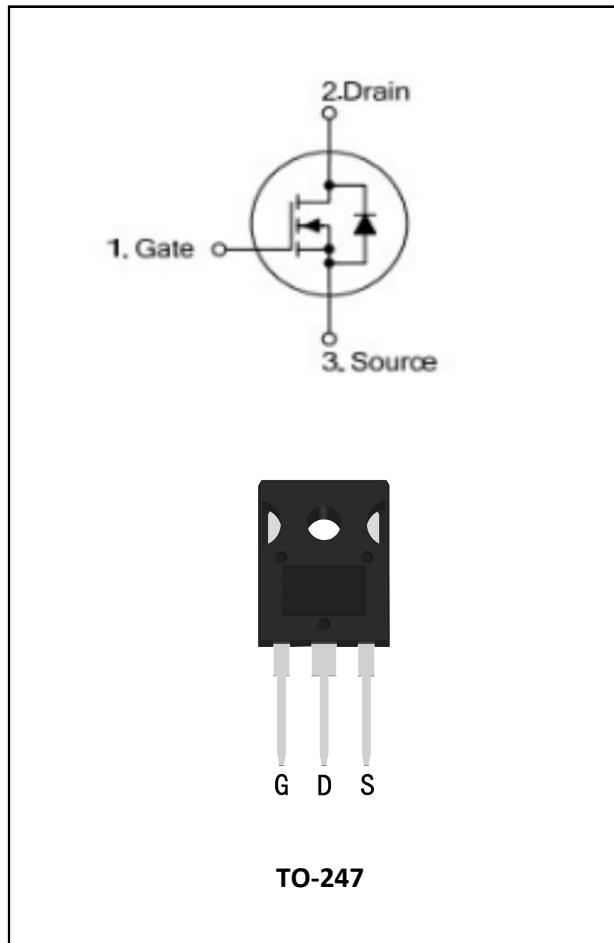
Parameter	Value	Unit
V <sub>DS</sub>	200	V
I <sub>D</sub>	18	A
R <sub>DS(ON).Typ</sub>	0.13	Ω

## FEATURES

- ① Fast Switching
- ② Low Crss
- ③ 100% avalanche tested
- ④ Improved dv/dt capability
- ⑤ RoHS product

## APPLICATIONS

High frequency switching mode power supply



## ORDERING INFORMATION

Ordering Codes	Package	Product Code	Packing
IRFP240	TO-247	IRFP240	Tube

## ABSOLUTE RATINGS at TC = 25°C, unless otherwise specified

Symbol	Parameter	Rating	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	200	V
I <sub>D</sub>	Continuous Drain Current	18	A
	Continuous Drain Current T <sub>c</sub> = 100 °C	11	A
I <sub>DM</sub>	Pulsed Drain Current(Note1)	72	A
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy(Note2)	580	mJ
dV/dt	Peak Diode Recovery dV/dt(Note3)	5.0	V/ns
P <sub>D</sub>	Power Dissipation TO-220, TO-251, TO-252	130	W
	Derating Factor above 25°C	1.2	W/°C



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P <sub>D</sub>	Power Dissipation TO-220F	42	W
	Derating Factor above 25°C	0.33	W/°C
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
T <sub>L</sub>	Maximum Temperature for Soldering	300	°C

### Thermal characteristics

#### Thermal characteristics (No FullPAK) TO-220\TO-251\TO-252

Symbol	Parameter	RATINGS	Units
R <sub>θJC</sub>	Junction-to-Case	0.84	°C/W
R <sub>θJA</sub>	Junction-to-Ambient	62.5	°C/W

#### Thermal characteristics (FullPAK) TO-220F

Symbol	Parameter	RATINGS	Units
R <sub>θJC</sub>	Junction-to-Case	3.0	°C/W
R <sub>θJA</sub>	Junction-to-Ambient	62.5	°C/W

### Electrical Characteristics at TC = 25°C, unless otherwise specified

OFF Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
V <sub>DSS</sub>	Drain to Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	200	--	--	V
ΔBV <sub>DSS</sub> /Δ T <sub>J</sub>	Bvdss Temperature Coefficient	I <sub>D</sub> =250uA, Reference25°C	--	0.25	--	V/°C
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> =200V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 25°C	--	--	1	μA
		V <sub>DS</sub> =160V, V <sub>GS</sub> = 0V, T <sub>i</sub> = 125 °C	--	--	100	μA
I <sub>GSS(F)</sub>	Gate to Source Forward Leakage	V <sub>GS</sub> =+30V	--	--	100	nA
I <sub>GSS(R)</sub>	Gate to Source Reverse Leakage	V <sub>GS</sub> =-30V	--	--	-100	nA



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### ON Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
R <sub>DS(ON)</sub>	Drain-to-Source On- Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =7.5A(Note4)	--	0.13	0.18	Ω
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA(Note4)	2.0	--	4.0	V
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =15V, I <sub>D</sub> =9A(Note4)	--	12	--	S

### Dynamic Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
R <sub>g</sub>	Gate resistance	f = 1.0MHz	--	2	--	Ω
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V	--	1320	--	PF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 25V	--	450	--	
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1.0MHz	--	130	--	

### Switching Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
t <sub>d(ON)</sub>	Turn-on Delay Time	I <sub>D</sub> =18A V <sub>DD</sub> = 100V V <sub>GS</sub> = 10V R <sub>G</sub> =20Ω	--	15	--	ns
T <sub>r</sub>	Rise Time		--	52	--	
t <sub>d(OFF)</sub>	Turn-Off Delay Time		--	46	--	
t <sub>f</sub>	Fall Time		--	37	--	
Q <sub>g</sub>	Total Gate Charge	ID =18A VDD =160V VGS = 10V	--	23	--	nC
Q <sub>gs</sub>	Gate to Source Charge		--	8	--	
Q <sub>gd</sub>	Gate to Drain ("Miller")Charge		--	6	--	

### Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
I <sub>s</sub>	Continuous Source Current (Body Diode)	T <sub>c</sub> =25 °C	--	--	18	A
I <sub>SM</sub>	Maximum Pulsed Current (Body Diode)		--	--	72	A
V <sub>SD</sub>	Diode Forward Voltage	I <sub>s</sub> =18A, V <sub>GS</sub> =0V(Note4)	--	--	1.2	V
T <sub>rr</sub>	Reverse Recovery Time	I <sub>s</sub> =18A, T <sub>j</sub> = 25°C d <sub>IF</sub> /d <sub>t</sub> =100A/us, V <sub>GS</sub> =0V	--	350	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge		--	3600	--	nC

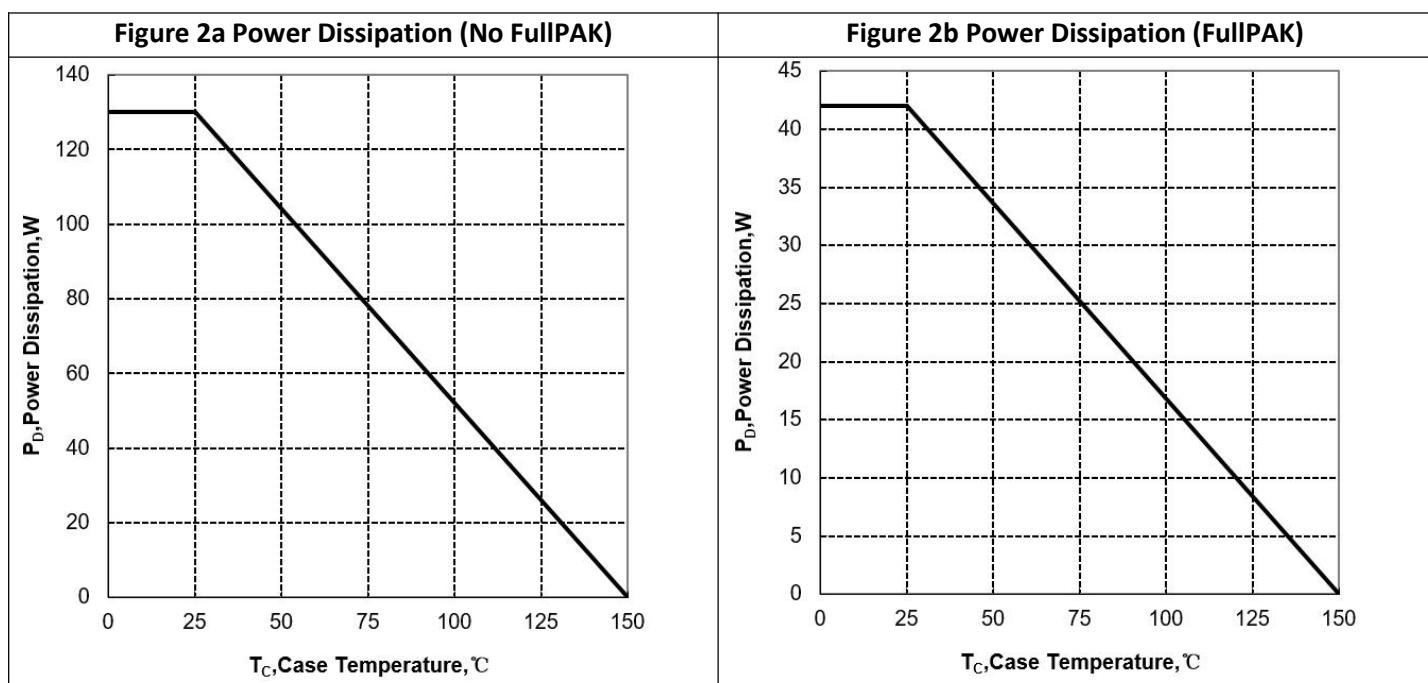
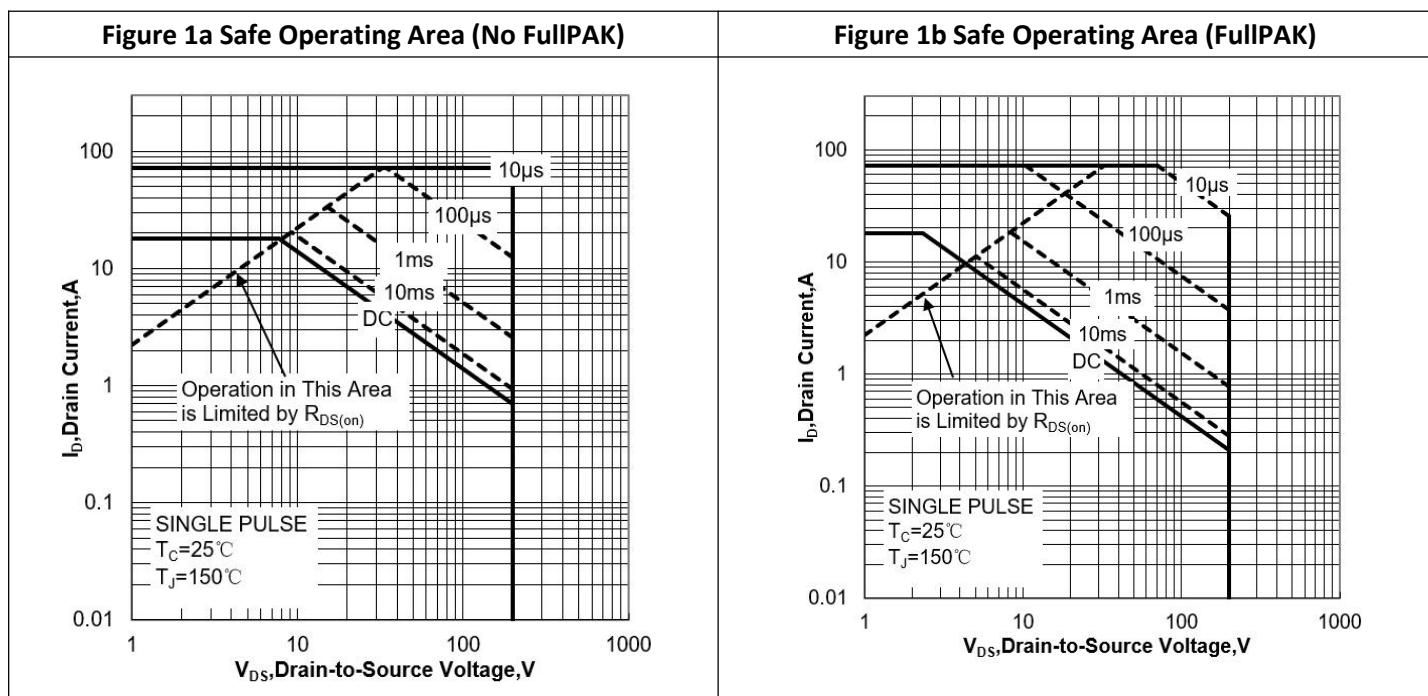
Note1: Pulse width limited by maximum junction temperature

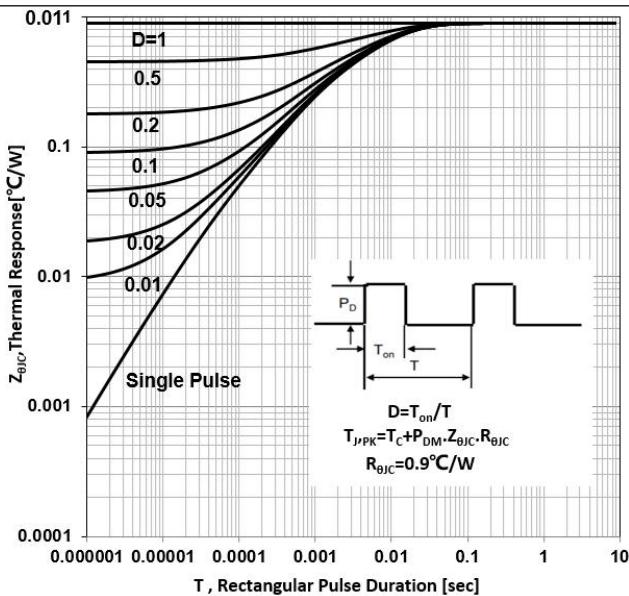
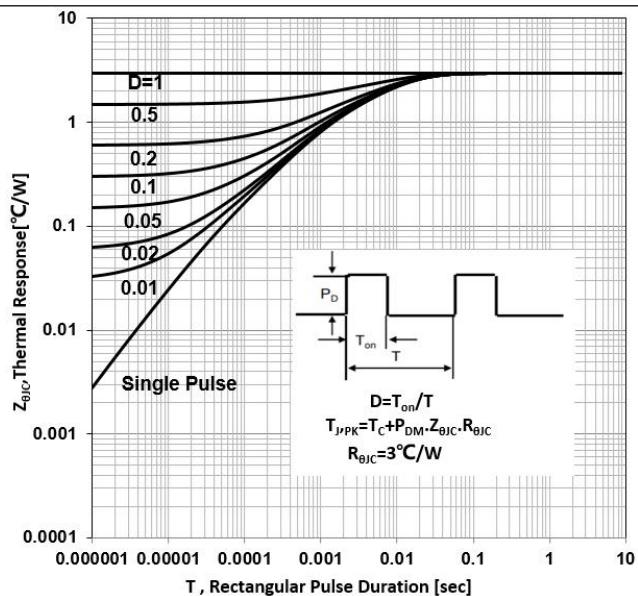
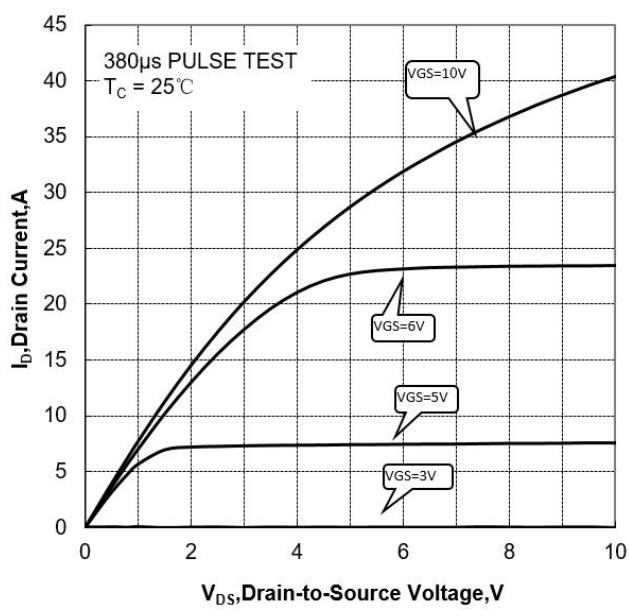
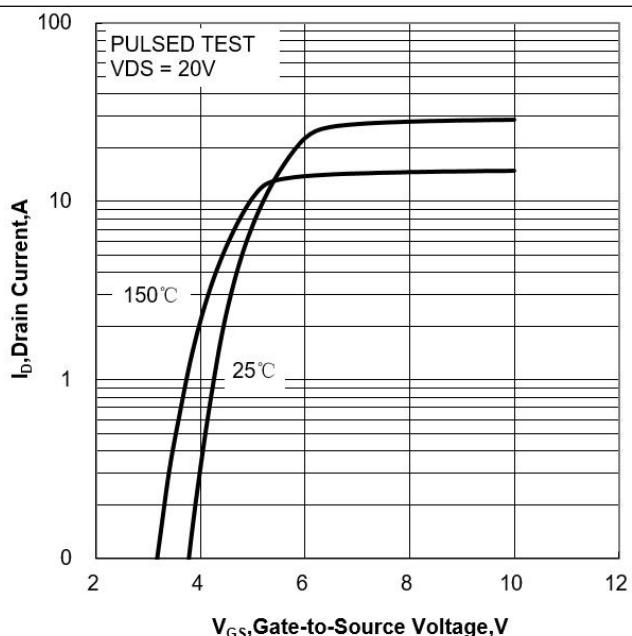
Note2: L=2.7mH, V<sub>DS</sub>=50V, Start T<sub>J</sub>=25 °C

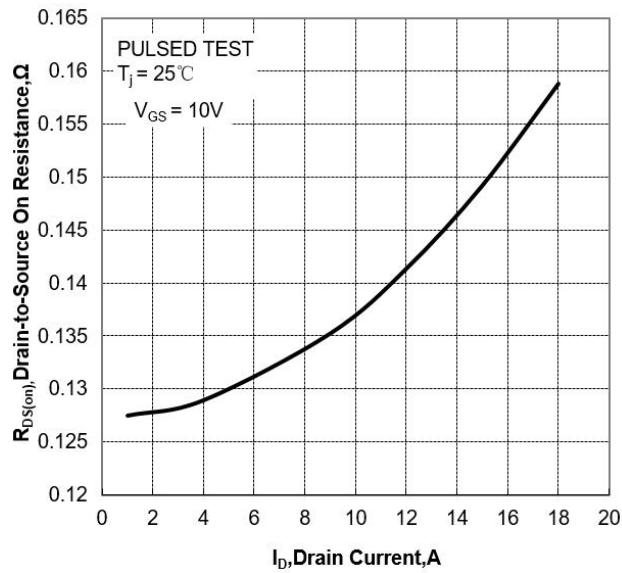
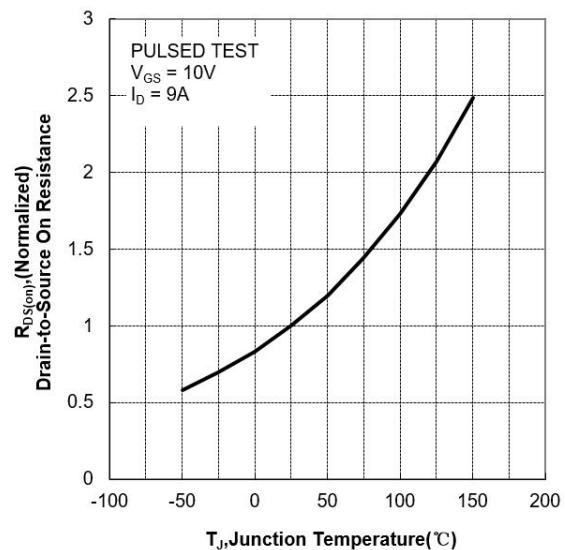
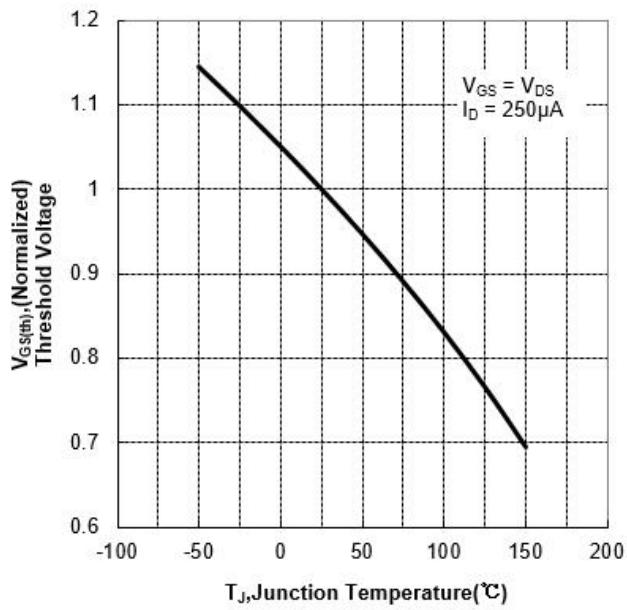
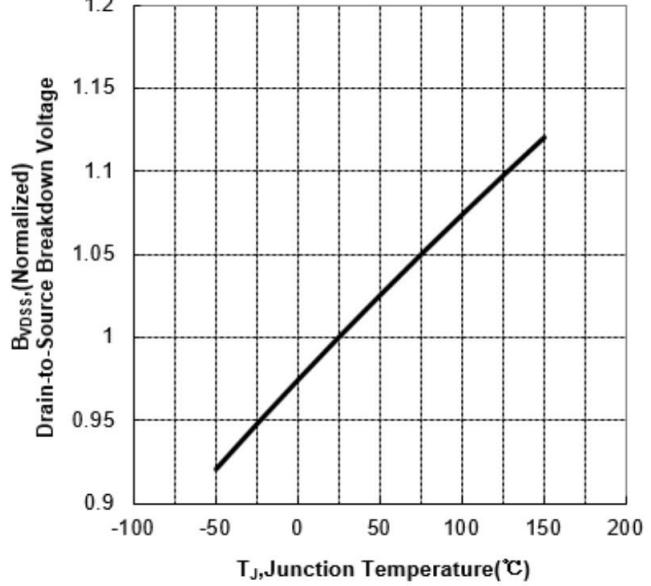
Note3: ISD =18A,di/dt ≤100A/us,VDD≤BVDS, Start T<sub>J</sub>=25 °C

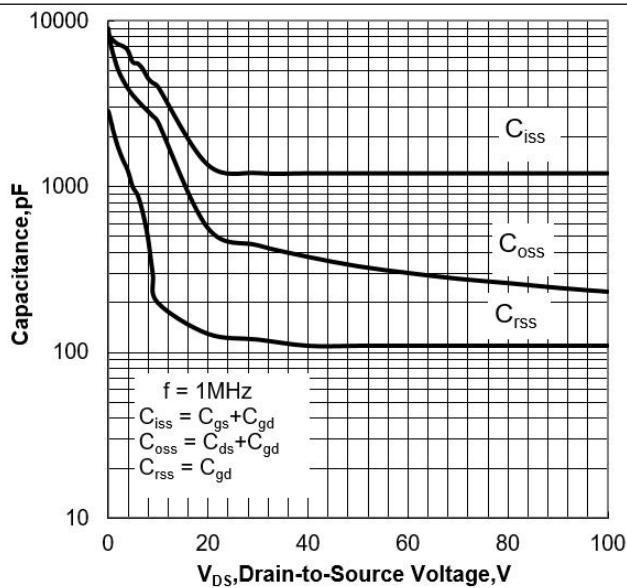
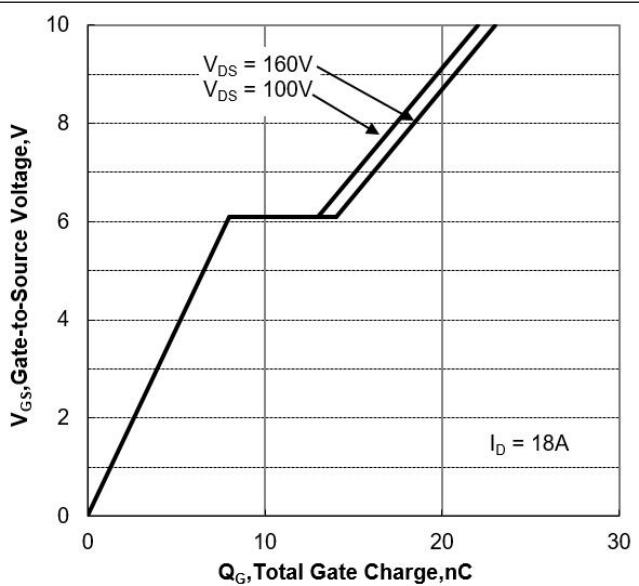
Note4: Pulse width tp≤300μs, δ≤2%

## Characteristics Curves



**Figure 3a Max Thermal Impedance (No FullPAK)**

**Figure 3b Max Thermal Impedance (FullPAK)**

**Figure 4 Typical Output Characteristics**

**Figure 5 Typical Transfer Characteristics**


**Figure 6 Typical Drain to Source ON Resistance vs Drain Current**

**Figure 7 Typical Drian to Source on Resistance vs Junction Temperature**

**Figure 8 Typical Threshold Voltage vs Junction Temperature**

**Figure 9 Typical Breakdown Voltage vs Junction Temperature**


**Figure 10 Capacitance Characteristics**

**Figure 11 Gate Charge Characteristics**


## Test Circuit and Waveform

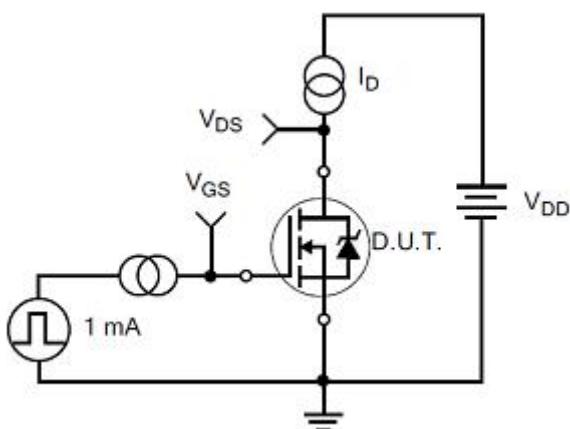
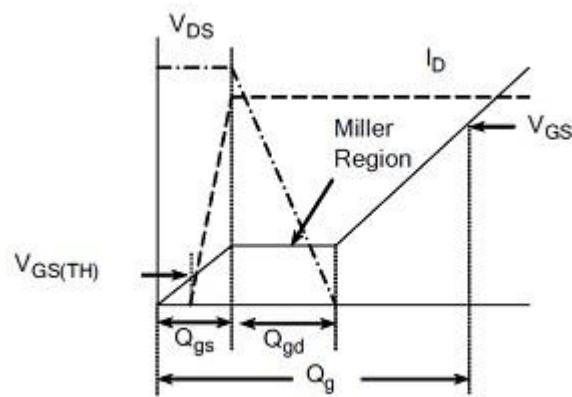
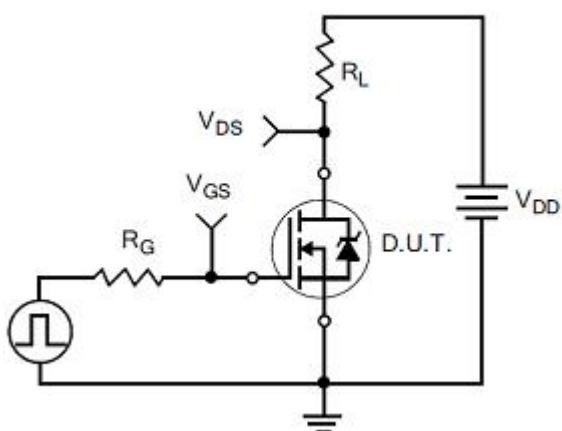
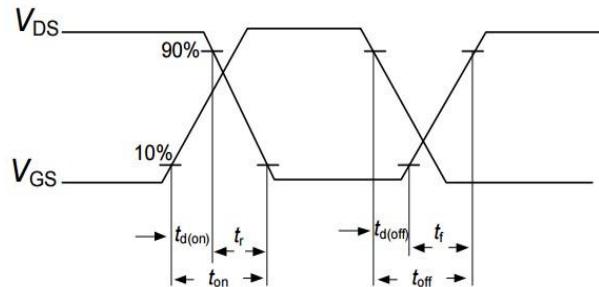
**Figure 12 Gate Charge Test Circuit**

**Figure 13 Gate Charge Waveforms**

**Figure 14 Resistive Switching Test Circuit**

**Figure 15 Resistive Switching Waveforms**


Figure 16 Diode Reverse Recovery Test Circuit

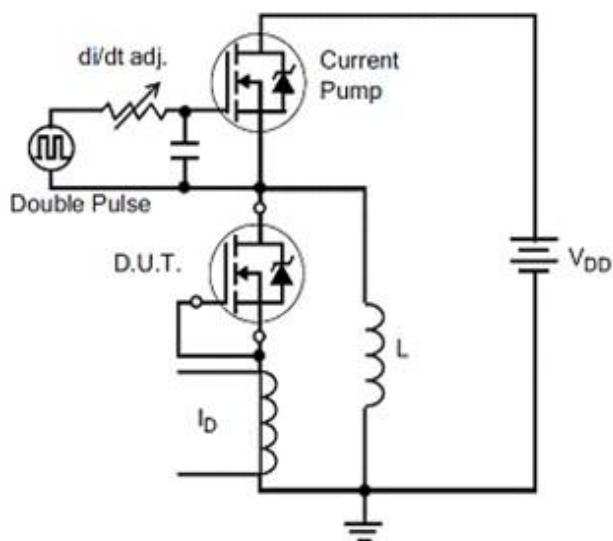


Figure 17 Diode Reverse Recovery Waveform

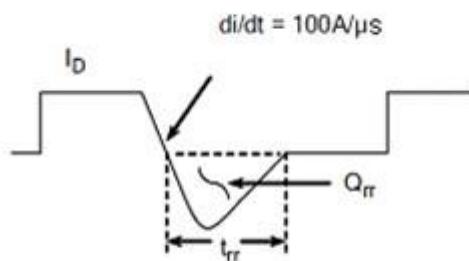


Figure 18 Unclamped Inductive Switching Test Circuit

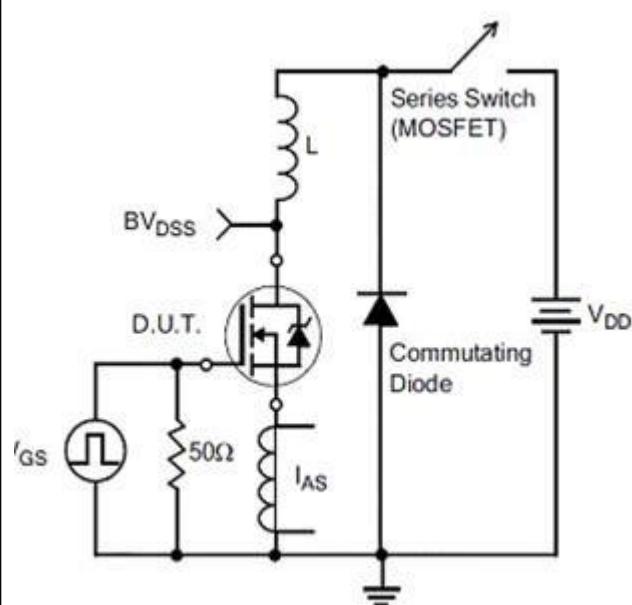
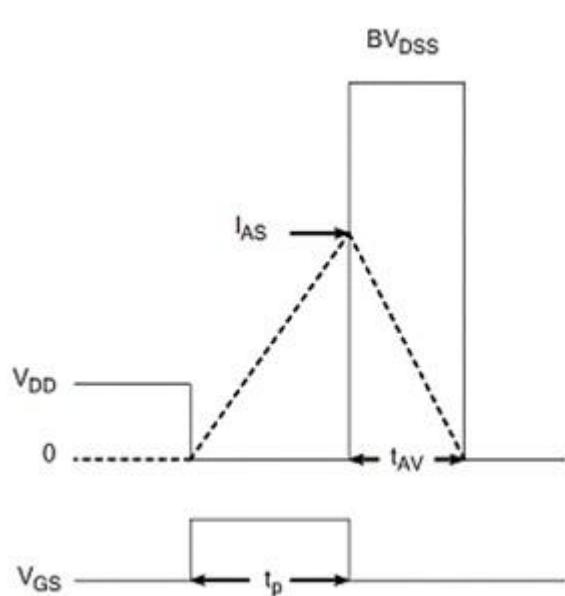
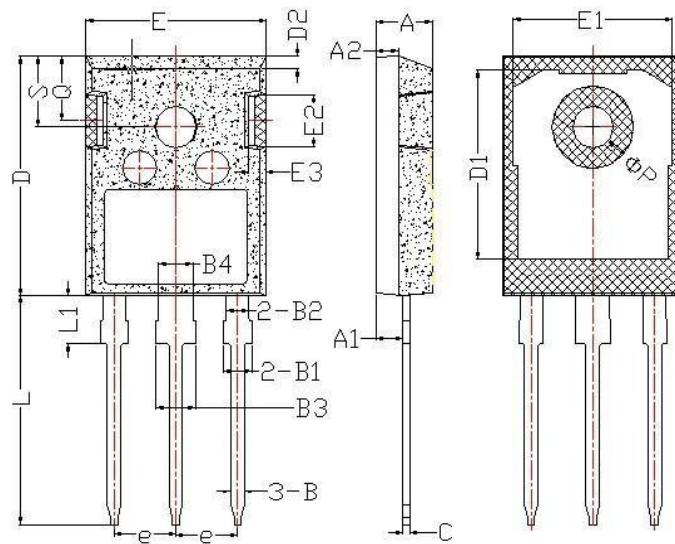


Figure 19 Unclamped Inductive Switching Waveform



## Package Description



Items	values (mm)	
	MIN	MAX
A	4.6	5.2
A1	2.2	2.6
B	0.9	1.4
B1	1.75	2.35
B2	1.75	2.15
B3	2.8	3.35
B4	2.8	3.15
C	0.5	0.7
D	20.60	21.30
D1	16	18
E	15.5	16.10
E1	13	14.7
E2	3.80	5.3
E3	0.8	2.60
e	5.2	5.7
L	19	20.5
L1	3.9	4.6
ΦP	2.5	3.70
Q	5.2	6.00
S	5.8	6.6

TO-247 Package

[www.mns-kx.com](http://www.mns-kx.com)



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#### NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

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